

**Search Notes**

Application/Control No.

10/677,522

Examiner

Seung H. Lee

Applicant(s)/Patent under  
Reexamination

BARKAN ET AL.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	462.38,39, 40	9/13/2005	SHL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
235	454	9/13/2005	SHL
235	462.38	9/13/2005	SHL
235	462.39	9/13/2005	SHL
235/462.40		9/13/2005	SHL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
235/454 (see printouts)	9/13/2005	SHL
T. Le	9/13/2005	SHL